Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/518,391	YOSHIDA ET AL.	
Examiner	Art Unit	
Matthew Landau	2815	

	SEARCHED					
Class	Subclass	Date	Examiner			
257	295, 421, 425, E43.004, E31.663.— E31.665	10/406	Î			
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365	145,158	+	1			

INT	INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner			
257	295,421, 425,	10/1/06	1			
	E43.663 –					
365	Ea1.665 145,158	-				
(see EAST printing)		0	+			

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
EXST Search (printout included)	10/165	~		
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